

L Number	Hits	Search Text	DB	Time stamp
11	675	250/\$.ccls. and focus\$5 and beam and filter and voltage with (wafer sustrate sample specimen)	USPAT; EPO; JPO; DERWENT	2004/05/07 11:20
12	501	((250/\$.ccls. and focus\$5 and beam and filter and voltage with (wafer sustrate sample specimen)) and intensit\$5	USPAT; EPO; JPO; DERWENT	2004/05/07 11:21
13	430	((250/\$.ccls. and focus\$5 and beam and filter and voltage with (wafer sustrate sample specimen)) and intensit\$5) and lens	USPAT; EPO; JPO; DERWENT	2004/05/07 11:21
14	305	((((250/\$.ccls. and focus\$5 and beam and filter and voltage with (wafer sustrate sample specimen)) and intensit\$5) and lens) and image	USPAT; EPO; JPO; DERWENT	2004/05/07 11:21
15	144	(((((250/\$.ccls. and focus\$5 and beam and filter and voltage with (wafer sustrate sample specimen)) and intensit\$5) and lens) and image) and filter same voltage	USPAT; EPO; JPO; DERWENT	2004/05/07 11:21
-	2	((("5404012") or ("6548810")).PN.	USPAT;	2004/05/07 11:19
-	0	energy near4 (cutoff cut-off) adj voltage same focus\$5 and 250/\$.ccls. and image	USPAT; EPO; JPO; DERWENT	2004/05/07 10:59
-	0	energy near4 (cutoff cut-off) adj voltage and 250/\$.ccls. and image	USPAT; EPO; JPO; DERWENT	2004/05/07 10:59
-	17	(cutoff cut-off) adj voltage and 250/\$.ccls. and image	USPAT; EPO; JPO; DERWENT	2004/05/07 11:00
-	7	((cutoff cut-off) adj voltage and 250/\$.ccls. and image) and energy	USPAT; EPO; JPO; DERWENT	2004/05/07 11:02
-	5	((((cutoff cut-off) adj voltage and 250/\$.ccls. and image) and energy) and focus\$6	USPAT; EPO; JPO; DERWENT	2004/05/07 11:03